

FDZ4676

N-Channel PowerTrench® MOSFET BGA

30V, 14A, 7.0mΩ

Features

- Max $r_{DS(on)}$ = 7.0mΩ at $V_{GS} = 10V$, $I_D = 14A$
- Max $r_{DS(on)}$ = 12mΩ at $V_{GS} = 4.5V$, $I_D = 10A$
- Ultra-thin package: less than 0.85mm height when mounted to PCB
- Outstanding thermal transfer characteristics
- Ultra-low gate charge x $r_{DS(on)}$ product
- RoHS Compliant

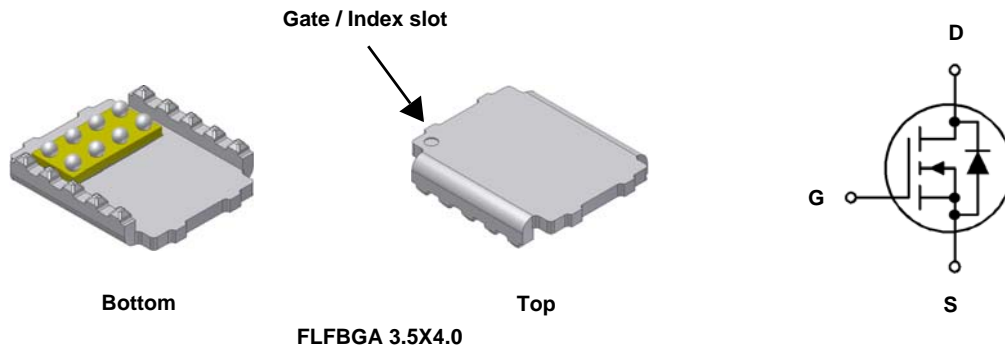


General Description

This part is optimized for very high density and high current synchronous buck converters using Fairchild's proprietary PowerTrench® process. This part has been tailored for the high side application, optimized both for low $r_{DS(on)}$, Q_g , and package parasitics; essential for high efficiency and fast switching. The part is offered in a standard format 3.5X4 footprint to offer both high side and low side in the same footprint. Partner low side FDZ4670 or FDZ4670S (SyncFET™ version).

Applications

- High Current POL
- DC-DC in server
- Networking
- High current microprocessor



MOSFET Maximum Ratings $T_A = 25^\circ\text{C}$ unless otherwise noted

Symbol	Parameter	Ratings	Units
V_{DS}	Drain to Source Voltage	30	V
V_{GS}	Gate to Source Voltage	± 20	V
I_D	Drain Current - Continuous	$T_A = 25^\circ\text{C}$ (Note 1a)	14
	- Pulsed		63
P_D	Power Dissipation	$T_A = 25^\circ\text{C}$ (Note 1a)	2.2
	Power Dissipation	$T_A = 25^\circ\text{C}$ (Note 1b)	1.1
T_J, T_{STG}	Operating and Storage Junction Temperature Range	-55 to +150	$^\circ\text{C}$

Thermal Characteristics

$R_{\theta JC}$	Thermal Resistance, Junction to Case	0.85	$^\circ\text{C/W}$
$R_{\theta JA}$	Thermal Resistance, Junction to Ambient (Note 1a)	56	
$R_{\theta JA}$	Thermal Resistance, Junction to Ambient (Note 1b)	110	

Package Marking and Ordering Information

Device Marking	Device	Package	Reel Size	Tape Width	Quantity
4676	FDZ4676	FLFBGA 3.5X4.0	13"	12mm	3000 units

Electrical Characteristics $T_J = 25^\circ\text{C}$ unless otherwise noted

Symbol	Parameter	Test Conditions	Min	Typ	Max	Units
--------	-----------	-----------------	-----	-----	-----	-------

Off Characteristics

BV_{DSS}	Drain to Source Breakdown Voltage	$I_D = 250\mu\text{A}, V_{GS} = 0\text{V}$	30			V
$\frac{\Delta BV_{DSS}}{\Delta T_J}$	Breakdown Voltage Temperature Coefficient	$I_D = 250\mu\text{A}$, referenced to 25°C		17		$\text{mV}/^\circ\text{C}$
I_{DSS}	Zero Gate Voltage Drain Current	$V_{GS} = 0\text{V}, V_{DS} = 24\text{V}$,			1	μA
I_{GSS}	Gate to Source Leakage Current	$V_{GS} = \pm 20\text{V}, V_{DS} = 0\text{V}$			± 100	nA

On Characteristics

$V_{GS(th)}$	Gate to Source Threshold Voltage	$V_{GS} = V_{DS}, I_D = 250\mu\text{A}$	1.0	1.8	3.0	V
$\frac{\Delta V_{GS(th)}}{\Delta T_J}$	Gate to Source Threshold Voltage Temperature Coefficient	$I_D = 250\mu\text{A}$, referenced to 25°C		-4		$\text{mV}/^\circ\text{C}$
$r_{DS(on)}$	Static Drain to Source On Resistance	$V_{GS} = 10\text{V}, I_D = 14\text{A}$		5.6	7.0	m Ω
		$V_{GS} = 4.5\text{V}, I_D = 10\text{A}$		9.0	12	
		$V_{GS} = 10\text{V}, I_D = 14\text{A}, T_J = 125^\circ\text{C}$		7.3	10	
g_{FS}	Forward Transconductance	$V_{DD} = 10\text{V}, I_D = 14\text{A}$		57		S

Dynamic Characteristics

C_{iss}	Input Capacitance	$V_{DS} = 15\text{V}, V_{GS} = 0\text{V}$, $f = 1\text{MHz}$		1000	1330	pF
C_{oss}	Output Capacitance			480	640	pF
C_{riss}	Reverse Transfer Capacitance			75	115	pF
R_g	Gate Resistance	$f = 1\text{MHz}$		0.67		Ω

Switching Characteristics

$t_{d(on)}$	Turn-On Delay Time	$V_{DD} = 15\text{V}, I_D = 14\text{A}$, $V_{GS} = 10\text{V}, R_{GEN} = 6\Omega$		7.5	15	ns
t_r	Rise Time			2.2	10	ns
$t_{d(off)}$	Turn-Off Delay Time			18	32	ns
t_f	Fall Time			1.6	10	ns
Q_g	Total Gate Charge		$V_{GS} = 10\text{V}$		16	22
Q_{gs}	Gate to Source Charge	$V_{DD} = 15\text{V}$, $I_D = 14\text{A}$		3		nC
Q_{gd}	Gate to Drain "Miller" Charge			2.4		nC

Drain-Source Diode Characteristics

V_{SD}	Source to Drain Diode Forward Voltage	$V_{GS} = 0\text{V}, I_S = 1.8\text{A}$ (Note 2)		0.7	1.2	V
t_{rr}	Reverse Recovery Time	$I_F = 14\text{A}, di/dt = 100\text{A}/\mu\text{s}$		28	45	ns
Q_{rr}	Reverse Recovery Charge			12	19	nC

NOTES:

1. $R_{\theta JA}$ is determined with the device mounted on a 1in^2 pad 2 oz copper pad on a $1.5 \times 1.5\text{in.}$ board of FR-4 material. $R_{\theta JC}$ is guaranteed by design while $R_{\theta CA}$ is determined by the user's board design.



a. $56^\circ\text{C}/\text{W}$ when mounted on a 1in^2 pad of 2 oz copper.



b. $110^\circ\text{C}/\text{W}$ when mounted on a minimum pad of 2 oz copper.

2. Pulse Test: Pulse Width < $300\mu\text{s}$, Duty cycle < 2.0%.

Typical Characteristics $T_J = 25^\circ\text{C}$ unless otherwise noted

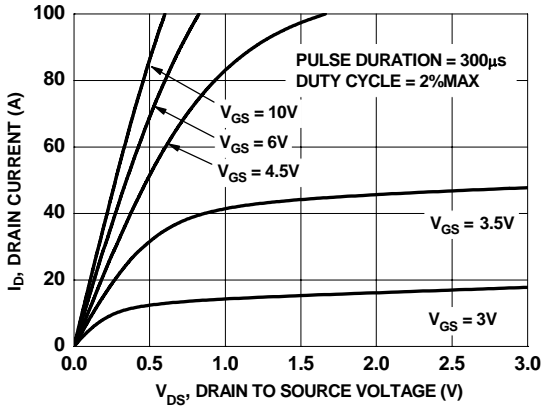


Figure 1. On-Region Characteristics

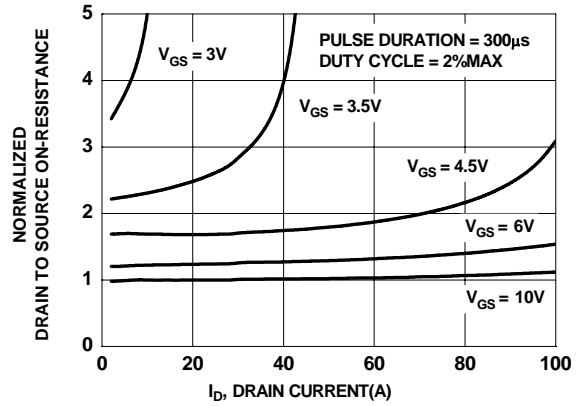


Figure 2. Normalized On-Resistance vs Drain Current and Gate Voltage

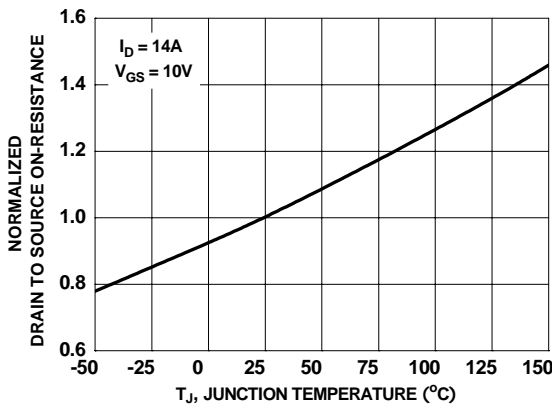


Figure 3. Normalized On-Resistance vs Junction Temperature

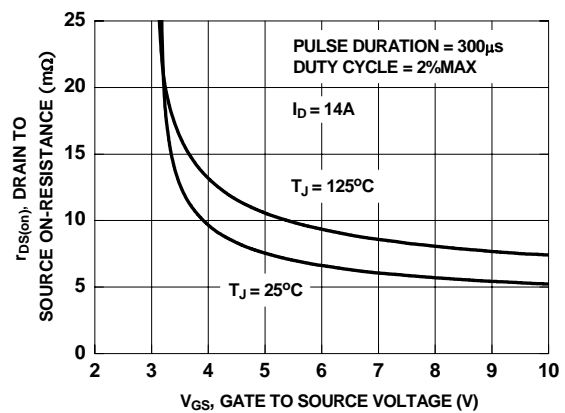


Figure 4. On-Resistance vs Gate to Source Voltage

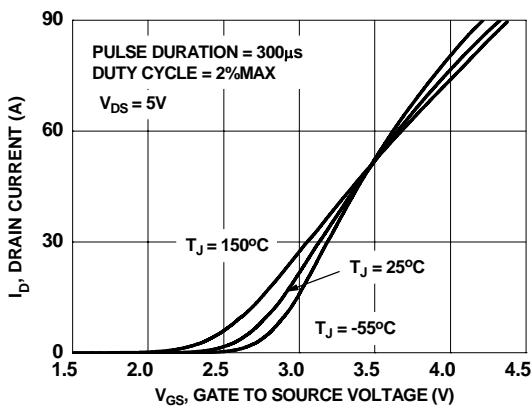


Figure 5. Transfer Characteristics

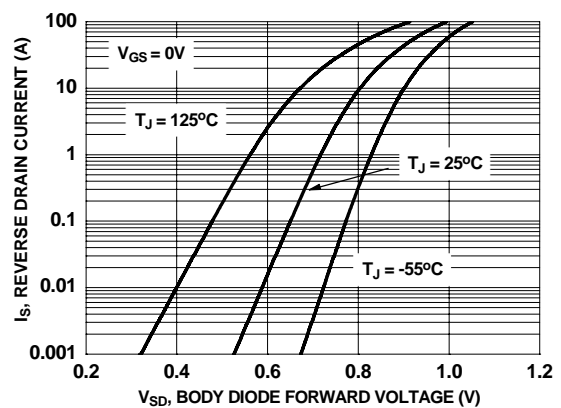


Figure 6. Source to Drain Diode Forward Voltage vs Source Current

Typical Characteristics $T_J = 25^\circ\text{C}$ unless otherwise noted

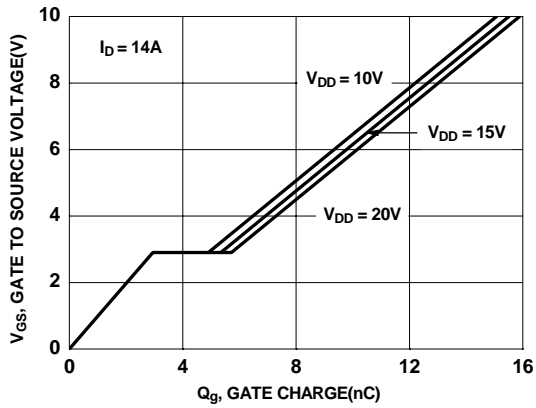


Figure 7. Gate Charge Characteristics

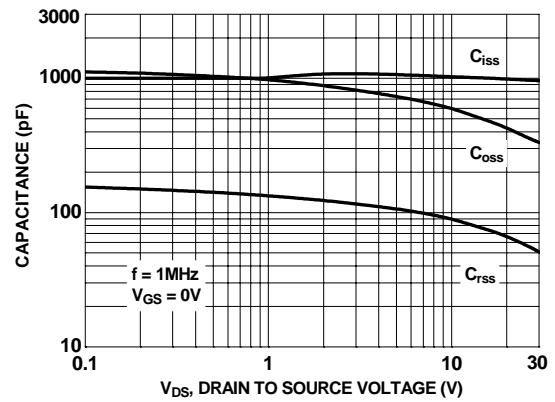


Figure 8. Capacitance vs Drain to Source Voltage

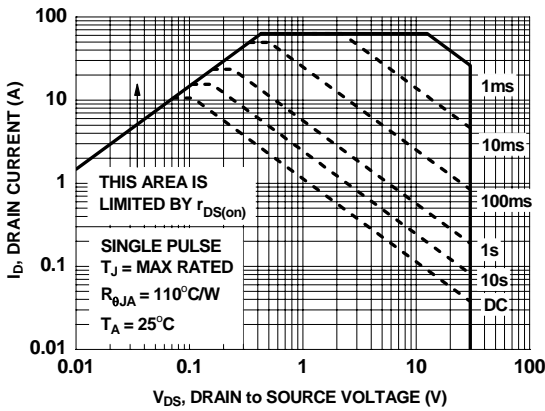


Figure 9. Forward Bias Safe Operating Area

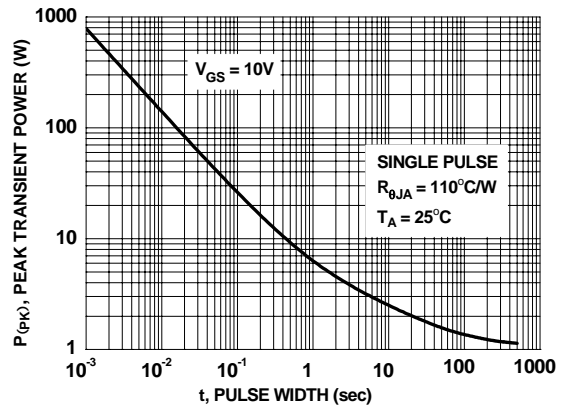


Figure 10. Single Pulse Maximum Power Dissipation

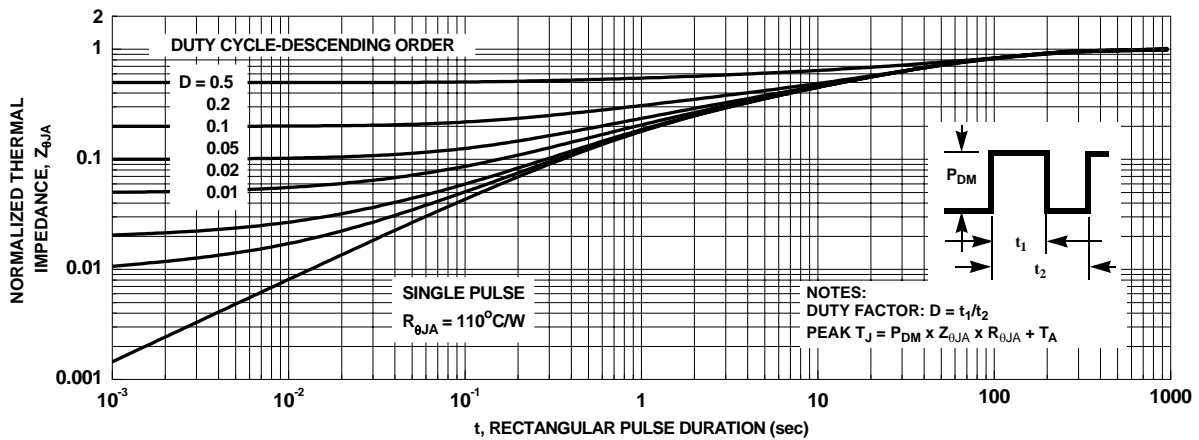
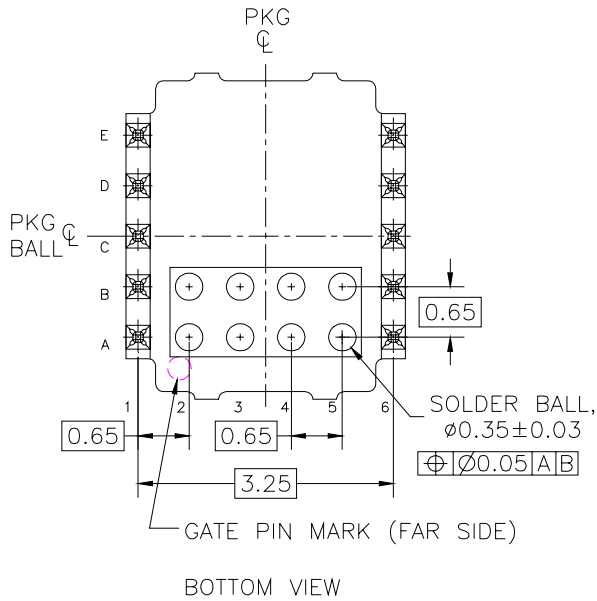
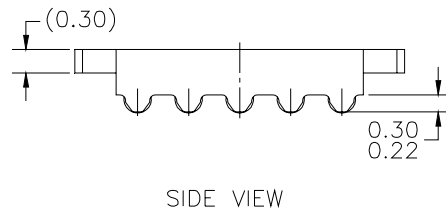
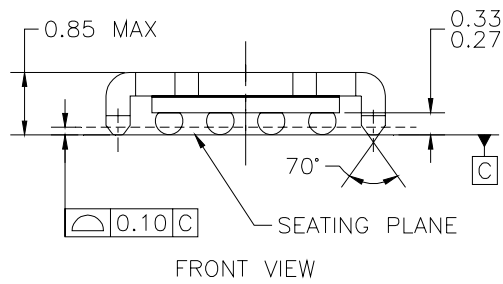
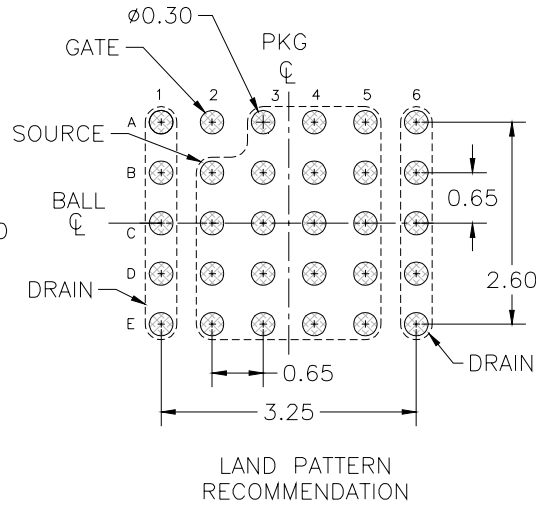
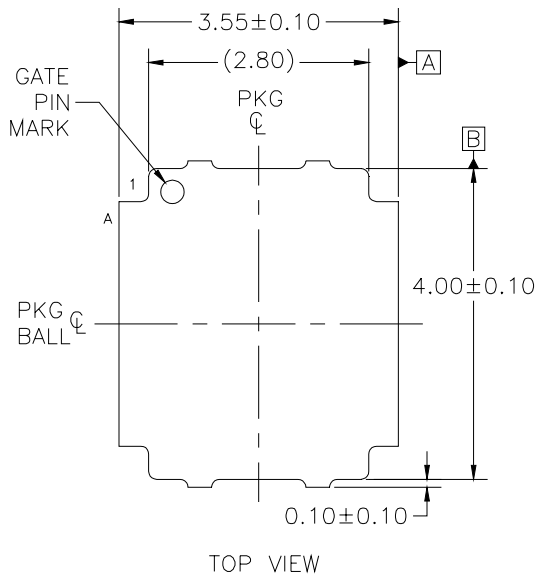


Figure 11. Transient Thermal Response Curve

Dimensional Outline and Pad Layout








- NOTES: UNLESS OTHERWISE SPECIFIED
- A) ALL DIMENSIONS ARE IN MILLIMETERS.
 - B) NO JEDEC REGISTRATION REFERENCE AS OF MARCH 2006.
 - C) TERMINAL CONFIGURATION TABLE
- | POSITION | DESIGNATION | TYPE |
|--------------------------------|-------------|-------------|
| A1,B1,C1,D1,E1, A6,B6,C6,D6,E6 | DRAIN | COPPER STUD |
| A2 | GATE | SOLDER BALL |
| A3,A4,A5,B2,B3, B4,B5 | SOURCE | SOLDER BALL |
- E) DRAWING FILE NAME: BGA18BREV1

BGA18BREV1



TRADEMARKS

The following includes registered and unregistered trademarks and service marks, owned by Fairchild Semiconductor and/or its global subsidiaries, and is not intended to be an exhaustive list of all such trademarks.

ACEx®	FPST™	PDP SPM™	The Power Franchise®
Build it Now™	F-PFS™	Power-SPM™	the power franchise
CorePLUS™	FRFET®	PowerTrench®	TinyBoost™
CorePOWER™	Global Power Resource™	Programmable Active Droop™	TinyBuck™
CROSSVOL™	Green FPS™	QFET®	TinyLogic®
CTL™	Green FPS™ e-Series™	QS™	TINYOPTO™
Current Transfer Logic™	GTO™	Quiet Series™	TinyPower™
EcoSPARK®	IntelliMAX™	RapidConfigure™	TinyPWM™
EfficientMax™	ISOPLANAR™	Saving our world, 1mW at a time™	SmartMax™
EZSWITCH™ *	MegaBuck™	SmartMax™	TinyWire™
 ™	MICROCOUPLER™	SMART START™	µSerDes™
 ®	MicroFET™	SPM®	 SerDes®
Fairchild®	MicroPak™	STEALTH™	UHC®
Fairchild Semiconductor®	MillerDrive™	SuperFET™	Ultra FRFET™
FACT Quiet Series™	MotionMax™	SuperSOT™-3	UniFET™
FACT®	Motion-SPM™	SuperSOT™-6	VCX™
FAST®	OPTOLOGIC®	SuperSOT™-8	VisualMax™
FastvCore™	OPTOPLANAR®	SupreMOS™	
FlashWriter® *		SyncFET™	
			

* EZSWITCH™ and FlashWriter® are trademarks of System General Corporation, used under license by Fairchild Semiconductor.

DISCLAIMER

FAIRCHILD SEMICONDUCTOR RESERVES THE RIGHT TO MAKE CHANGES WITHOUT FURTHER NOTICE TO ANY PRODUCTS HEREIN TO IMPROVE RELIABILITY, FUNCTION, OR DESIGN. FAIRCHILD DOES NOT ASSUME ANY LIABILITY ARISING OUT OF THE APPLICATION OR USE OF ANY PRODUCT OR CIRCUIT DESCRIBED HEREIN; NEITHER DOES IT CONVEY ANY LICENSE UNDER ITS PATENT RIGHTS, NOR THE RIGHTS OF OTHERS. THESE SPECIFICATIONS DO NOT EXPAND THE TERMS OF FAIRCHILD'S WORLDWIDE TERMS AND CONDITIONS, SPECIFICALLY THE WARRANTY THEREIN, WHICH COVERS THESE PRODUCTS.

LIFE SUPPORT POLICY

FAIRCHILD'S PRODUCTS ARE NOT AUTHORIZED FOR USE AS CRITICAL COMPONENTS IN LIFE SUPPORT DEVICES OR SYSTEMS WITHOUT THE EXPRESS WRITTEN APPROVAL OF FAIRCHILD SEMICONDUCTOR CORPORATION.

As used herein:

1. Life support devices or systems are devices or systems which, (a) are intended for surgical implant into the body or (b) support or sustain life, and (c) whose failure to perform when properly used in accordance with instructions for use provided in the labeling, can be reasonably expected to result in a significant injury of the user.
2. A critical component in any component of a life support, device, or system whose failure to perform can be reasonably expected to cause the failure of the life support device or system, or to affect its safety or effectiveness.

PRODUCT STATUS DEFINITIONS

Definition of Terms

Datasheet Identification	Product Status	Definition
Advance Information	Formative / In Design	This datasheet contains the design specifications for product development. Specifications may change in any manner without notice.
Preliminary	First Production	This datasheet contains preliminary data; supplementary data will be published at a later date. Fairchild Semiconductor reserves the right to make changes at any time without notice to improve design.
No Identification Needed	Full Production	This datasheet contains final specifications. Fairchild Semiconductor reserves the right to make changes at any time without notice to improve the design.
Obsolete	Not In Production	This datasheet contains specifications on a product that is discontinued by Fairchild Semiconductor. The datasheet is for reference information only.

Rev. I34